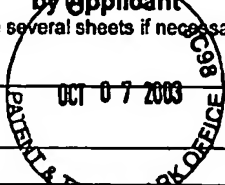


Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 07977-291001	Application No. 10/043,786
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Satoshi Seo et al.	
		Filing Date January 10, 2002	Group Art Unit 2879



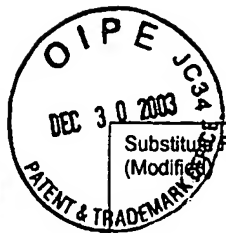
U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA						
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Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
S.R.	AQ	Takeshi Nishi et al., "High Efficiency TFT-OLED Display with Iridium-Complex As Triplet Emissive Center", <i>Proceedings of the 10th International Workshop on Inorganic and Organic Electroluminescence</i> , pp. 353-356, December 4-7, 2000
	AR	
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Examiner Signature <i>Sikha Roy</i>	Date Considered 4/23/04
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Substitute Form PTO-1449
(Modified)U.S. Department of Commerce
Patent and Trademark OfficeAttorney's Docket No.
07977-291001Application No.
10/043,786**Information Disclosure Statement
by Applicant**

(Use several sheets if necessary)

(37 CFR §1.98(b))

Applicant
Satoshi Seo et al.Filing Date
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2879**U.S. Patent Documents**

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
S.R.	AA	4,725,513	02/16/1988	Eguchi, et al.			03/03/1987
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							Yes	No
S.R.	AD	EP 1 011 155 B1	06/04/2003	EUROPE			In English	
S.R.	AE	2000-208262	07/28/2000	JAPAN			Full	
	AF							
	AG							
	AH							
	AI							
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	AO							

Other Documents (Include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
	AP	Sinapore Patent Application No. 200200037-0 Search and Examination Report dated November 18, 2003 (8 pages)
	AQ	
	AR	
	AS	

Examiner Signature

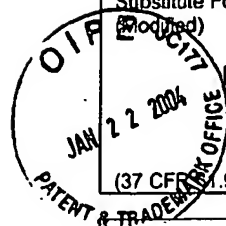
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S.R.	AA	2003/0134145 A1	07/17/2003	Toguchi, et al.			
S.R.	AB	6,396,209 B1	05/28/2002	Kido, et al.			
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Foreign Patent Documents or Published Foreign Patent Applications

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							Yes	No
S.R.	AF	2000-208262	07/28/2000	Japan				x
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	AI							
	AJ							

Other Documents (include Author, Title, Date, and Place of Publication)

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	AM	
	AN	
	AO	

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